

**Search Notes**

Application/Control No.

09/775,040

Examiner

Hanh Phan

Applicant(s)/Patent under  
Reexamination

BISCHOFF, MATHIAS

Art Unit

2638

SEARCHED			
Class	Subclass	Date	Examiner
398	59 82	09/12/08	HP
	83, 9		
	45, 50		
	48, 71		
	91, 100		
	56, 58		
	182, 183		
	89, 78		
update	search	09/12/08	HP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search see attached print out in the file - IEEE search. Jposearch.	09/12/08	HP
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